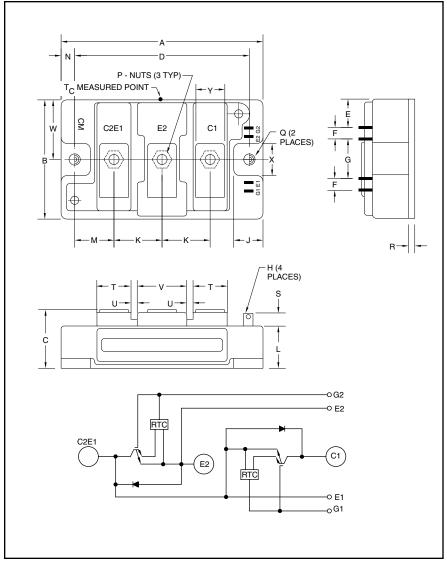


# Trench Gate Design Dual IGBTMOD™ 50 Amperes/1200 Volts



#### **Outline Drawing and Circuit Diagram**

Dimension	s Inches	Millimeters		
Α	3.70	94.0		
В	1.89	48.0		
С	1.18 +0.04/-0.02	30.0 +1.0/-0.5		
D	3.15±0.01	80.0±0.25		
Е	0.43	11.0		
F	0.16	4.0		
G	0.71	18.0		
Н	0.02	0.5		
J	0.53	13.5		
K	0.91	23.0		
L	0.83	21.2		
М	0.67	17.0		

ns Inches Millimet		
0.28	7.0	
M5	M5	
Dia. 0.26	6.5 Dia.	
0.02	4.0	
0.30	7.5	
0.63	16.0	
0.10	2.5	
1.0	25.0	
0.94	24.0	
0.51	13.0	
0.47	12.0	
0.47	12.0	
	0.28 M5 Dia. 0.26 0.02 0.30 0.63 0.10 1.0 0.94 0.51 0.47	



#### **Description:**

Powerex IGBTMOD™ Modules are designed for use in switching applications. Each module consists of two IGBT Transistors in a half-bridge configuration with each transistor having a reverse-connected super-fast recovery free-wheel diode. All components and interconnects are isolated from the heat sinking baseplate, offering simplified system assembly and thermal management.

### Features:

- ☐ Low Drive Power
- ☐ Low VCE(sat)
- ☐ Discrete Super-Fast Recovery Free-Wheel Diode
- ☐ Isolated Baseplate for Easy Heat Sinking

#### **Applications:**

- ☐ AC Motor Control
- □ UPS
- □ Battery Powered Supplies

### **Ordering Information:**

Example: Select the complete module number you desire from the table - i.e. CM50DU-24Fis a 1200V (VCES), 50 Ampere Dual IGBTMOD™ Power Module.

Туре	Current Rating Amperes	VCES Volts (x 50)			
СМ	50	24			



CM50DU-24F Trench Gate Design Dual IGBTMOD™ 50 Amperes/1200 Volts

## Absolute Maximum Ratings, $T_j = 25^{\circ}\text{C}$ unless otherwise specified

Ratings	Symbol	CM50DU-24F	Units
Junction Temperature	Тј	-40 to 150	°C
Storage Temperature	T <sub>stg</sub>	-40 to 125	°C
Collector-Emitter Voltage (G-E SHORT)	V <sub>CES</sub>	1200	Volts
Gate-Emitter Voltage (C-E SHORT)	VGES	±20	Volts
Collector Current (T <sub>C</sub> = 25°C)	IC	50	Amperes
Peak Collector Current	ICM	100*	Amperes
Emitter Current** (T <sub>C</sub> = 25°C)	ΙΕ	50	Amperes
Peak Emitter Current**	IEM	100*	Amperes
Maximum Collector Dissipation (T <sub>C</sub> = 25°C, T <sub>j</sub> ≤ 150°C)	P <sub>C</sub>	320	Watts
Mounting Torque, M5 Main Terminal		31	in-lb
Mounting Torque, M6 Mounting	_	40	in-lb
Weight	_	310	Grams
Isolation Voltage (Main Terminal to Baseplate, AC 1 min.)	V <sub>iso</sub>	2500	Volts

## Static Electrical Characteristics, $T_j = 25^{\circ}\text{C}$ unless otherwise specified

Characteristics	Symbol	Test Conditions	Min.	Тур.	Max.	Units
Collector-Cutoff Current	ICES	$V_{CE} = V_{CES}$ , $V_{GE} = 0V$	-	-	1	mA
Gate Leakage Current	IGES	$V_{GE} = V_{GES}, V_{CE} = 0V$	-	-	20	μΑ
Gate-Emitter Threshold Voltage	VGE(th)	$I_C = 5mA$ , $V_{CE} = 10V$	5	6	7	Volts
Collector-Emitter Saturation Voltage	V <sub>CE(sat)</sub>	$I_C = 50A$ , $V_{GE} = 15V$ , $T_j = 25$ °C	-	1.8	2.4	Volts
		$I_C = 50A$ , $V_{GE} = 15V$ , $T_j = 125$ °C	-	1.9	-	Volts
Total Gate Charge	QG	$V_{CC} = 600V$ , $I_{C} = 50A$ , $V_{GE} = 15V$	-	550	-	nC
Emitter-Collector Voltage**	V <sub>EC</sub>	I <sub>E</sub> = 50A, V <sub>GE</sub> = 0V	-	_	3.2	Volts

<sup>\*</sup> Pulse width and repetition rate should be such that the device junction temperature (Ti) does not exceed Ti(max) rating.

<sup>\*\*</sup> Represents characteristics of the anti-parallel, emitter-to-collector free-wheel diode (FWDi).



CM50DU-24F Trench Gate Design Dual IGBTMOD™ 50 Amperes/1200 Volts

## Dynamic Electrical Characteristics, T<sub>i</sub> = 25°C unless otherwise specified

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Characteristics		Symbol	Test Conditions	Min.	Typ.	Max.	Units
Input Capacita	nce	C <sub>ies</sub>		-	-	20	nf
Output Capaci	tance	C <sub>oes</sub>	$V_{CE} = 10V$ , $V_{GE} = 0V$	_	_	0.85	nf
Reverse Transf	fer Capacitance	C <sub>res</sub>		_	-	0.5	nf
Inductive	Turn-on Delay Time	<sup>t</sup> d(on)	V <sub>CC</sub> = 600V, I <sub>C</sub> = 50A,	-	_	100	ns
Load	Rise Time	t <sub>r</sub>	$V_{GE1} = V_{GE2} = 15V$ ,	_	_	50	ns
Switch	Turn-off Delay Time	td(off)	$R_G = 6.3\Omega$ ,	_	_	300	ns
Times	Fall Time	tf	Inductive Load	-	_	300	ns
Diode Reverse	Recovery Time**	t <sub>rr</sub>	Switching Operation	_	_	150	ns
Diode Reverse	Recovery Charge**	Q <sub>rr</sub>	I <sub>E</sub> = 50A	_	2.1	_	μC

# Thermal and Mechanical Characteristics, $T_j$ = 25 °C unless otherwise specified

Characteristics	Symbol	Test Conditions	Min.	Тур.	Max.	Units
Thermal Resistance, Junction to Case	R <sub>th(j-c)</sub> Q	Per IGBT 1/2 Module, T <sub>C</sub> Reference	_		0.39	°C/W
	• ,	Point per Outline Drawing				
Thermal Resistance, Junction to Case	R <sub>th(j-c)</sub> D	Per FWDi 1/2 Module, T <sub>C</sub> Reference	_	_	0.70	°C/W
	• ,	Point per Outline Drawing				
Thermal Resistance, Junction to Case	R <sub>th(j-c)</sub> 'Q	Per IGBT 1/2 Module,	_	0.26		°C/W
	• ,	T <sub>C</sub> Reference Point Under Chip				
Contact Thermal Resistance	R <sub>th(c-f)</sub>	Per Module, Thermal Grease Applied	_	0.045	_	°C/W

<sup>\*\*</sup> Represents characteristics of the anti-parallel, emitter-to-collector free-wheel diode (FWDi).



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